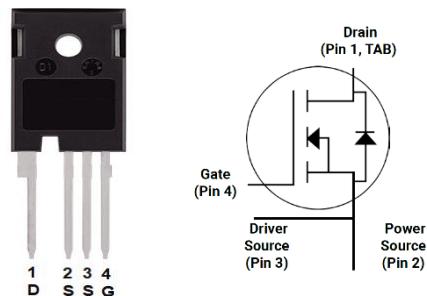


## Product Summary

$V_{DS} = 1200\text{ V}$   
 $I_D@25^\circ\text{C} = 64\text{ A}$   
 $R_{DS(\text{ON})} = 40\text{ m}\Omega$   
 AEC-Q101 in Progress



TO-247-4

## Features

- High Blocking Voltage
- High Frequency Operation
- Low on-resistance
- Fast intrinsic diode with low reverse recovery

## Benefits

- Higher System Efficiency
- Parallel Device Convenience without thermal runaway
- High Temperature Application
- Hard Switching & Higher Reliability
- Easy to drive

## Applications

- Motor Drives
- Solar / Wind Inverters
- EV Charging Station
- AC/DC converters
- DC/DC converters
- Uninterruptable power supplies

## Maximum Ratings ( $T_c=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test conditions	Value	Unit
Drain - Source Voltage	$V_{DS\text{max}}$	$V_{GS}=0\text{V}, I_D=100\mu\text{A}$	1200	V
Gate - Source Voltage (dynamic)	$V_{GS\text{max}}$	AC ( $f>1\text{ Hz}$ )	-10 / +25	V
Gate - Source Voltage (static)	$V_{GS\text{op}}$	static	-5 / +20	V
Continuous Drain Current	$I_D$	$V_{GS} = 20\text{V}, T_c=25^\circ\text{C}$ $V_{GS} = 20\text{V}, T_c=100^\circ\text{C}$	64 45	A
Pulsed Drain Current	$I_{D(\text{pulse})}$	$T_c=25^\circ\text{C}$	112	A
Short Circuit Capability	$t_{SC}$	$V_{DD}=800\text{V}, V_{GS}=20\text{V}$	3.5	$\mu\text{s}$
Short Circuit Capability	$I_{DS}$	$V_{DD}=800\text{V}, V_{GS}=20\text{V}$	600	A
Total power dissipation	$P_D$	$T_c=25^\circ\text{C}$	333	W
Operating Junction Temperature	$T_J$		-55 to 175	$^\circ\text{C}$
Storage Temperature	$T_{STG}$		-55 to 175	$^\circ\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

**Electrical Characteristics** ( $T_C=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Test conditions	Min	Typ	Max	Unit	
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0\text{V}, I_D = 100\mu\text{A}$	1200			V	
Gate Threshold Voltage		$V_{DS} = V_{GS}, I_D = 10\text{mA}$	1.8	3.4	3.9	V	
		$V_{DS} = V_{GS}, I_D = 10\text{mA}, T_J = 150^\circ\text{C}$		2.5			
		$V_{DS} = V_{GS}, I_D = 10\text{mA}, T_J = 175^\circ\text{C}$		2.4		V	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 1200\text{V}, V_{GS} = 0\text{V}$	0	5	100	$\mu\text{A}$	
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS} = 20\text{V}, V_{DS} = 0\text{V}$	0	10	200	nA	
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS} = -5\text{V}, V_{DS} = 0\text{V}$	-200	-10	0	nA	
Drain-Source On-State Resistance	$R_{DS(\text{on})}$	$V_{GS} = 18\text{V}, I_D = 40 \text{ A}$		47		$\text{m}\Omega$	
		$V_{GS} = 18\text{V}, I_D = 40 \text{ A}, T_J = 150^\circ\text{C}$		65			
		$V_{GS} = 18\text{V}, I_D = 40 \text{ A}, T_J = 175^\circ\text{C}$		73			
		$V_{GS} = 20\text{V}, I_D = 40 \text{ A}$		40	50		
		$V_{GS} = 20\text{V}, I_D = 40 \text{ A}, T_J = 150^\circ\text{C}$		60			
		$V_{GS} = 20\text{V}, I_D = 40 \text{ A}, T_J = 175^\circ\text{C}$		67			
Transconductance	$g_{fs}$	$V_{DS} = 20\text{V}, I_D = 40 \text{ A}$		22		S	
		$V_{DS} = 20\text{V}, I_D = 40 \text{ A}, T_J = 150^\circ\text{C}$		19			
		$V_{DS} = 20\text{V}, I_D = 40 \text{ A}, T_J = 175^\circ\text{C}$		19			
Input capacitance	$C_{iss}$	$V_{DS} = 1000\text{V}, V_{GS} = 0\text{V}$ $f = 1\text{MHz}$		2930		pF	
Output capacitance	$C_{oss}$			149			
Reverse transfer capacitance	$C_{rss}$			9			
$C_{oss}$ Stored Energy	$E_{oss}$			87			
Total gate charge	$Q_g$	$V_{DS} = 800\text{V}, V_{GS} = -5\text{V} / 20\text{V}$ $I_D = 40 \text{ A}$		145		nC	
Gate-source charge	$Q_{gs}$			43			
Gate-drain charge	$Q_{gd}$			73			
Internal gate input resistance	$R_{g(\text{int})}$	$f = 1\text{MHz}, I_D = 0\text{A}$		2		$\Omega$	
Turn-On Switching Energy	$E_{ON}$	$V_{DS} = 800 \text{ V}, V_{GS} = -5\text{V}/20\text{V}$ $I_D = 40\text{A}, R_{G(\text{ext})} = 2\Omega$ , $L = 200\mu\text{H}$		240		$\mu\text{J}$	
Turn-Off Switching Energy	$E_{OFF}$			80			
Turn-On Delay Time	$t_{d(\text{on})}$			12			
Rise Time	$t_r$			16			
Turn-Off Delay Time	$t_{d(\text{off})}$			27			
Fall Time	$t_f$			7			
Avalanche Capability	$E_{AS}$	$V_{DD} = 100\text{V}, V_{GS}=20\text{V}, L=2\text{mH}$		400		mJ	
Avalanche Capability	$I_{AV}$	$V_{DD} = 100\text{V}, V_{GS}=20\text{V}, L=2\text{mH}$		20		A	

**Reverse Diode Characteristics** ( $T_C=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Diode Forward Voltage	$V_{SD}$	$V_{GS} = -5V, I_{SD} = 20A,$		3.9		V
		$V_{GS} = -5V, I_{SD} = 20A, T_J = 150^\circ\text{C}$		3.7		
		$V_{GS} = -5V, I_{SD} = 20A, T_J = 175^\circ\text{C}$		3.6		
Continuous Diode Forward Current	$I_S$	$V_{GS} = -5V$		70		A
Reverse Recovery time	$t_{rr}$	$V_{GS} = -5V, I_{SD} = 40A,$		17		ns
Reverse Recovery Charge	$Q_{rr}$			310		nC
Peak Reverse Recovery Current	$I_{rrm}$	$V_R = 800V, \text{dif/dt} = 4200 A/\mu\text{s}$		30		A

**Thermal Characteristics**

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Thermal Resistance (per device)	$R_{th(j-c)}$	junction-case		0.34	0.45	°C/W

## Typical Performance

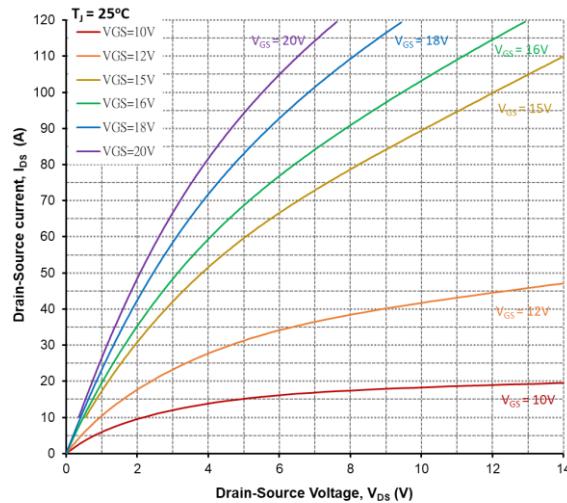


Figure 1. Output Characteristics,  $T_J = 25^\circ\text{C}$

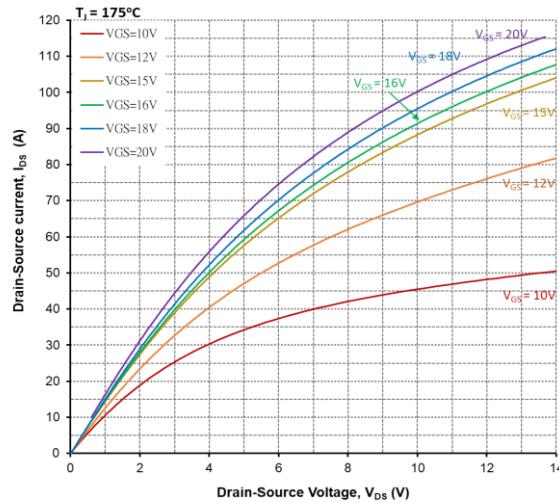


Figure 2. Output Characteristics,  $T_J = 175^\circ\text{C}$

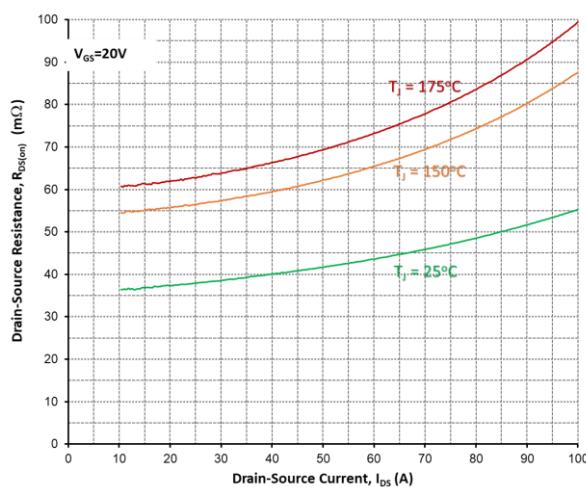


Figure 3. On-Resistance vs. Drain Current  
For Various Temperatures

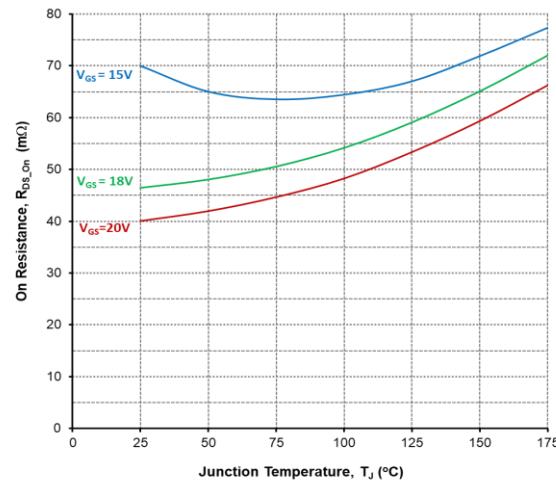


Figure 4. On-Resistance vs. Temperature

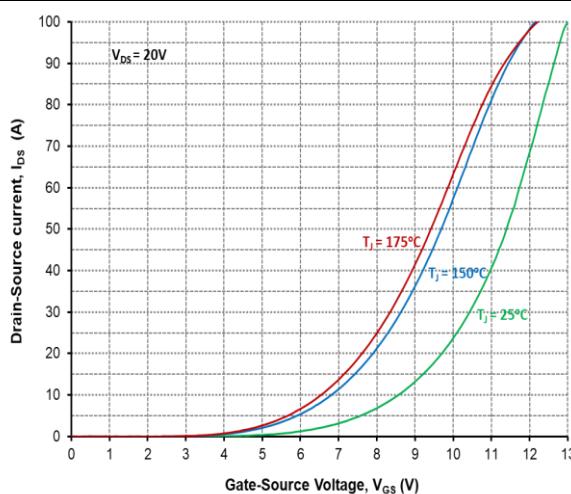


Figure 5. Transfer Characteristic For Various Junction Temperatures

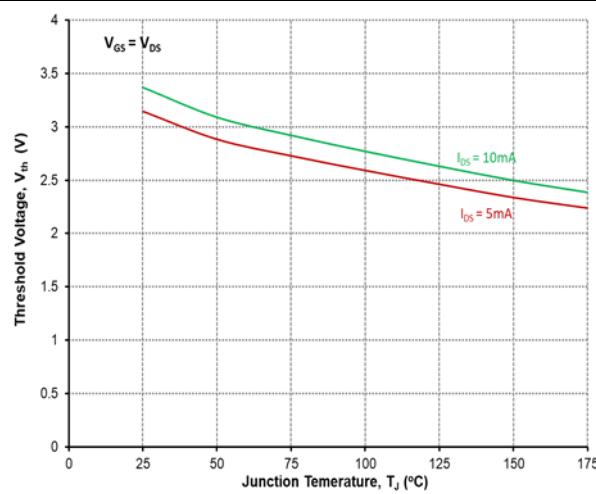


Figure 6. Threshold Voltage vs. Temperature

## Typical Performance

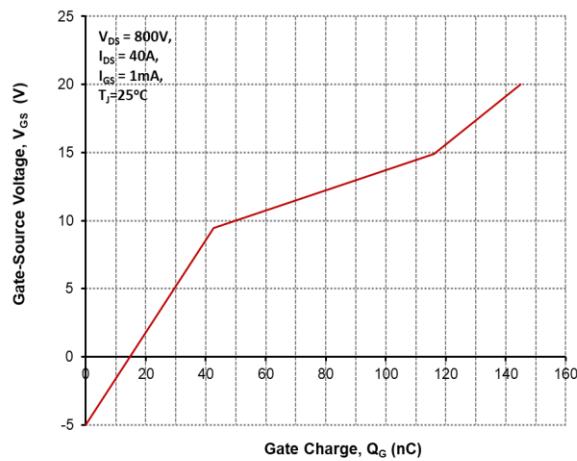


Figure 7. Gate Charge Characteristics

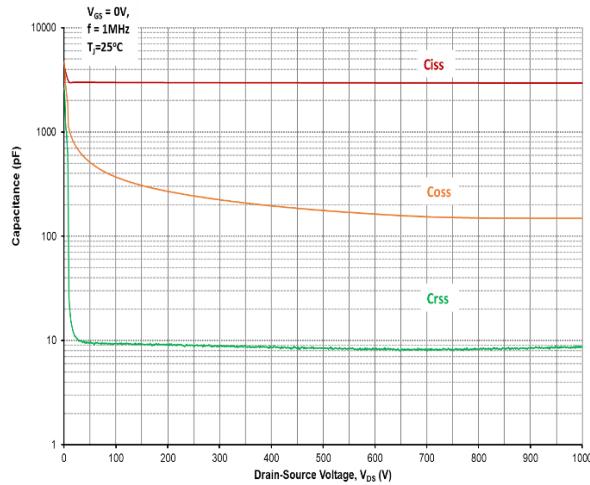


Figure 8. Capacitances vs. Drain-Source Voltage (0-1000V)

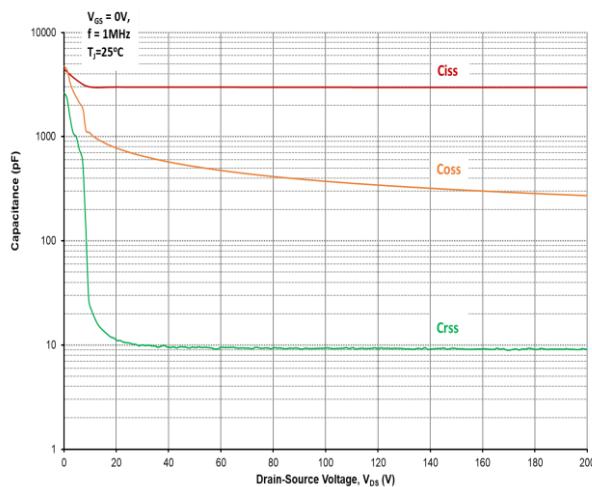


Figure 9. Capacitances vs. Drain-Source Voltage (0-200V)

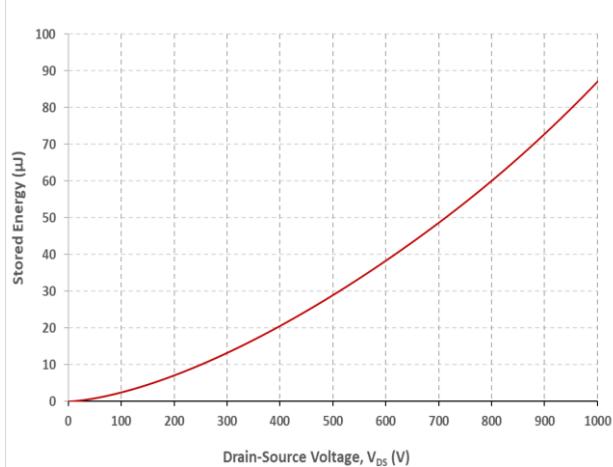


Figure 10. Output Capacitor Stored Energy

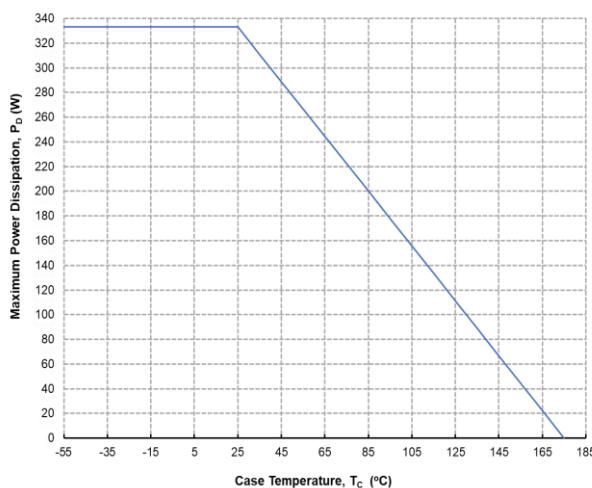


Figure 11. Maximum Power Dissipation Derating vs. Case Temperature

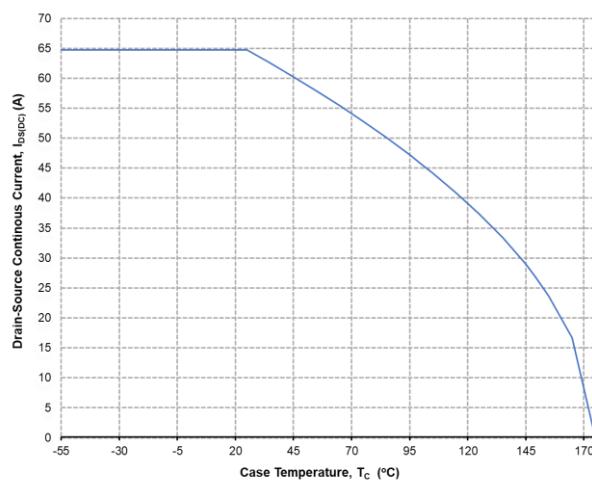


Figure 12. Continuous Drain Current Derating vs. Case Temperature

## Typical Performance

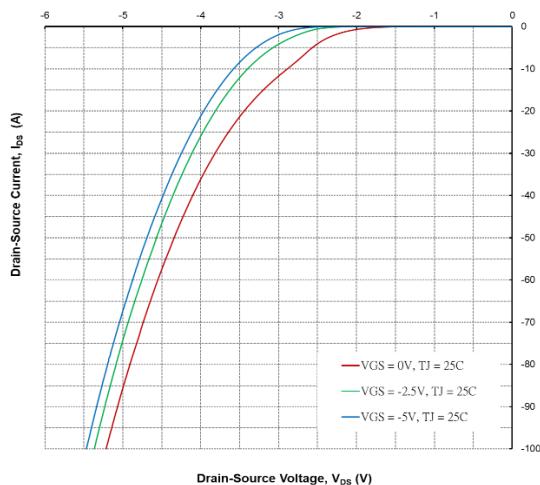


Figure 13. Body Diode Characteristics @ 25°C

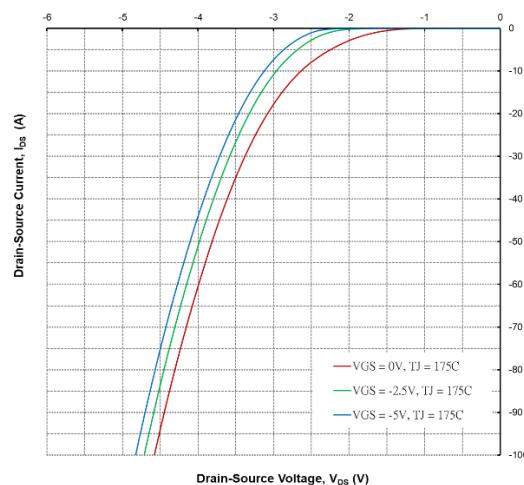


Figure 14. Body Diode Characteristics @ 175°C

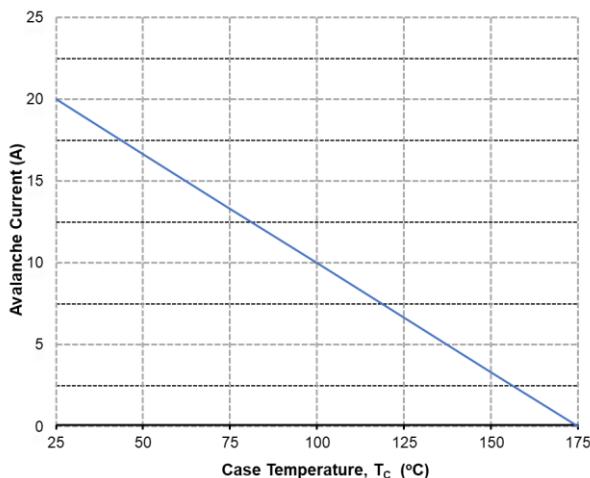


Figure 15. Single Avalanche vs. Temperature

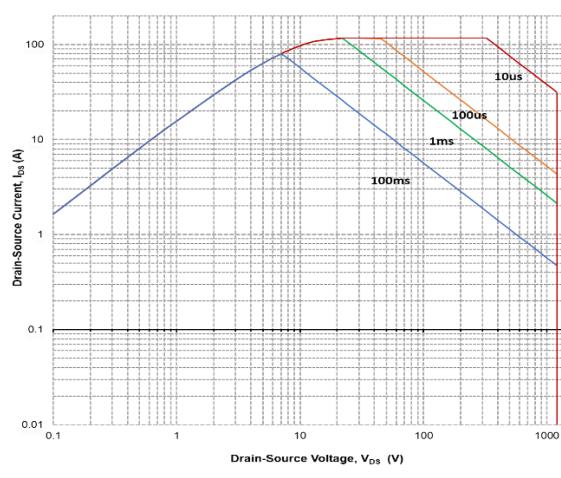
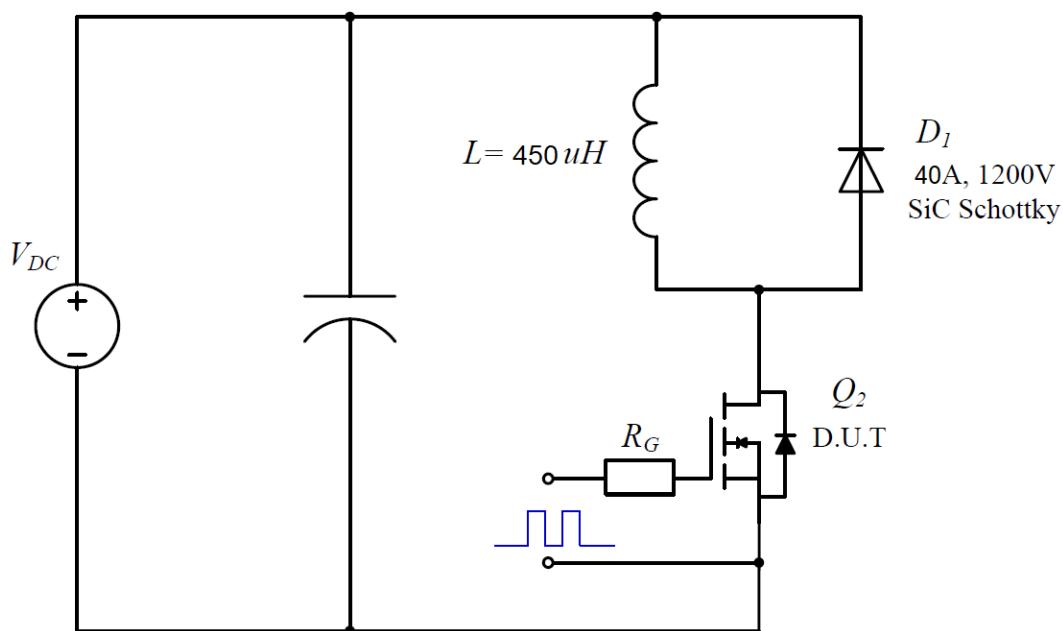
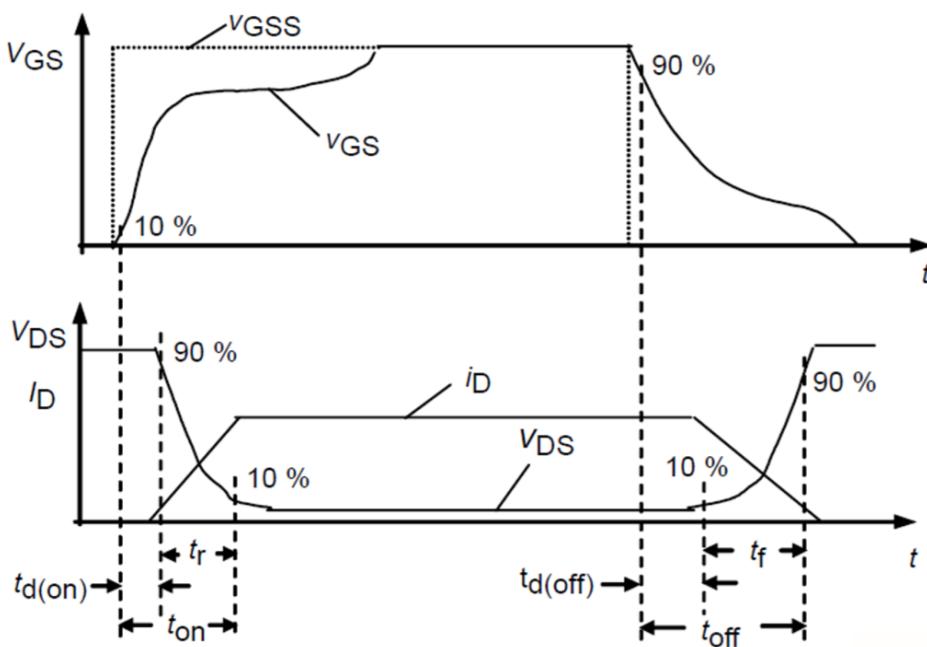


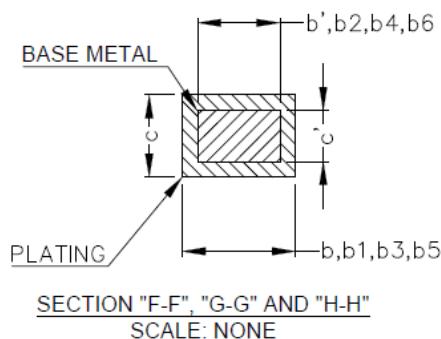
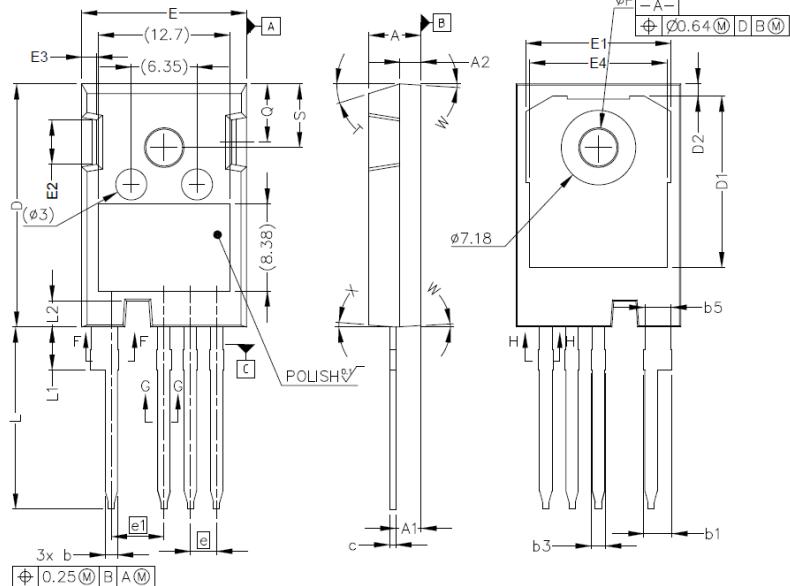
Figure 16. Safe Operating Area

## Switching Times Definition and Test Circuit



## Package Dimensions

(TO-247-4 Package)



SYMBOL	MILLIMETERS	
	MIN	MAX
A	4.83	5.21
A1	2.29	2.54
A2	1.91	2.16
b'	1.07	1.28
b	1.07	1.33
b1	2.39	2.94
b2	2.39	2.84
b3	1.07	1.60
b4	1.07	1.50
b5	2.39	2.69
b6	2.39	2.64
c'	0.55	0.65
c	0.55	0.68
D	23.30	23.60
D1	16.25	17.65
D2	0.95	1.25
E	15.75	16.13
E1	13.10	14.15
E2	3.68	5.10
E3	1.00	1.90
E4	12.38	13.43
e	2.54 BSC	
e1	5.08 BSC	
N	4	
L	17.31	17.82
L1	3.97	4.37
L2	2.35	2.65
øP	3.51	3.65
Q	5.49	6.00
S	6.04	6.30
T	17.5° REF.	
W	3.5 ° REF.	
X	4 ° REF.	

NOTE :

1. ALL METAL SURFACES: TIN PLATED, EXCEPT AREA OF CUT
2. DIMENSIONING & TOLERANCING CONFIRM TO ASME Y14.5M-1994.
3. ALL DIMENSIONS ARE IN MILLIMETERS.  
ANGLES ARE IN DEGREES.